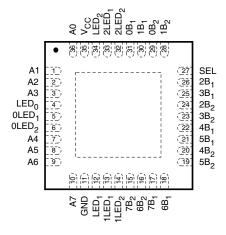
FEATURES

- Wide Bandwidth (BW = 1100 MHz Typ)
- Low Crosstalk (X_{TALK} = -37 dB Typ)
- Low Bit-to-Bit Skew (t_{sk(o)} = 100 ps Max)
- Low and Flat ON-State Resistance $(r_{ON} = 4 \Omega \text{ Typ}, r_{ON(flat)} = 0.5 \Omega \text{ Typ})$
- Low Input/Output Capacitance (C_{ON} = 8 pF Typ)
- Rail-to-Rail Switching on Data I/O Ports (0 to 5 V)
- V_{CC} Operating Range From 3 V to 3.6 V
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)

APPLICATIONS

- 10/100/1000 Base-T Signal Switching
- Differential (LVDS, LVPECL) Signal Switching
- Audio/Video Switching
- Hub and Router Signal Switching

RHH PACKAGE (TOP VIEW)



PIN DESCRIPTION

NAME	DESCRIPTION			
A _n	Data I/O			
nB _m	Data I/O			
SEL	Select input			
LED _x	LED I/O port			
XLED _m	LED I/O port			

DESCRIPTION/ORDERING INFORMATION

The TS3L4892 is a 16-bit to 8-bit multiplexer/demultiplexer LAN switch with a single select (SEL) input. SEL controls the data path of the multiplexer/demultiplexer. The device provides additional I/Os for switching status indicating LED signals.

The device provides a low and flat ON-state resistance (r_{ON}) and an excellent ON-state resistance match. Low input/output capacitance, high bandwidth, low skew, and low crosstalk among channels make this device suitable for various LAN applications, such as 10/100/1000 Base-T.

This device can be used to replace mechanical relays in LAN applications. It also can be used to route signals from a 10/100 Base-T ethernet transceiver to the RJ-45 LAN connectors in laptops or in docking stations.

ORDERING INFORMATION

T _A	PACKAGE	(1)(2)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	QFN – RHH	Tape and reel	TS3L4892RHHR	TK4892

(1) Package drawings, standard packing quantities, and symbolization are available at www.ti.com/packaging.

(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

FUNCTION TABLE

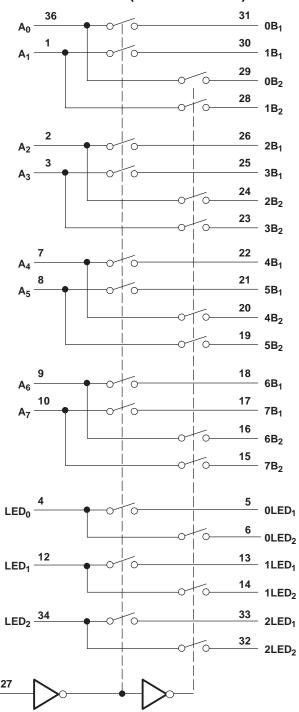
INPUT SEL	INPUT/OUTPUT A _n	FUNCTION
L	nB ₁	$A_n = nB_1$, $LED_x = XLED_1$
Н	nB_2	$A_n = nB_2$, $LED_x = XLED_2$



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



LOGIC DIAGRAM (POSITIVE LOGIC)



ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

				MIN	MAX	UNIT
V_{CC}	Supply voltage range			-0.5	4.6	V
V_{IN}	Control input voltage range ⁽²⁾⁽³⁾				7	V
V _{I/O}	Switch I/O voltage range ⁽²⁾⁽³⁾⁽⁴⁾				7	V
I _{IK}	Control input clamp current	V _{IN} < 0			-50	mA
I _{I/OK}	I/O port clamp current	I/O port clamp current $V_{I/O} < 0$				mA
I _{I/O}	ON-state switch current ⁽⁵⁾				±128	mA
	Continuous current through V _{DD} or GND				±100	mA
θ_{JA}	Package thermal impedance (6)				31.8	°C/W
T _{stg}	Storage temperature range			-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to ground, unless otherwise specified.

(4) V_I and V_O are used to denote specific conditions for V_{I/O}.

(5) I_{l} and I_{O} are used to denote specific conditions for $I_{l/O}$.

RECOMMENDED OPERATING CONDITIONS(1)

		MIN	MAX	UNIT
V_{CC}	Supply voltage	3	3.6	V
V_{IH}	High-level control input voltage (SEL)	2	5.5	V
V_{IL}	Low-level control input voltage (SEL)	0	0.8	V
VI	Input voltage (SEL)	0	5.5	V
V _{I/O}	Input/output voltage	0	V_{CC}	V
T _A	Operating free-air temperature	-40	85	°C

All unused control inputs of the device must be held at V_{DD} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

Product Folder Link(s): TS3L4892

⁽³⁾ The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

⁽⁶⁾ The package thermal impedance is calculated in accordance with JESD 51-7.



ELECTRICAL CHARACTERISTICS

for 1000 Base-T Ethernet switching over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted)

PARA	METER		TEST CONDI	TIONS ⁽¹⁾		MIN	TYP ⁽²⁾	MAX	UNIT
V _{IK}	SEL	V _{CC} = 3.6 V,	I _{IN} = -18 mA	$I_{IN} = -18 \text{ mA}$					V
I _{IH}	SEL	$V_{CC} = 3.6 \text{ V},$	$V_{IN} = V_{CC}$	$V_{IN} = V_{CC}$					μΑ
I _{IL}	SEL	$V_{CC} = 3.6 \text{ V},$	$V_{IN} = GND$					±1	μΑ
I _{CC}		$V_{CC} = 3.6 \text{ V},$	$I_{I/O} = 0$,	Switch ON or OF	F		250	500	μΑ
C _{IN}	SEL	f = 1 M Hz,	V _{IN} = 0				2	2.5	pF
C _{OFF}	B port	$V_I = 0$,	f = 1 MHz,	Outputs open,	Switch OFF		2.5	4	pF
C _{ON}		$V_I = 0$,	f = 1 MHz,	Outputs open,	Switch ON		8	9	pF
r _{ON}		$V_{CC} = 3 V$,	$1.5 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{CC}},$	$I_O = -40 \text{ mA}$			4	6	Ω
r _{ON(flat)} (3)		V _{CC} = 3 V,	$V_I = 1.5 \text{ V} \text{ and } V_{CC}$	I _O = -40 mA			0.5		Ω
$\Delta r_{ON}^{(4)}$		V _{CC} = 3 V,	$1.5 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{CC}},$	$I_O = -40 \text{ mA}$			0.4	1	Ω

- $V_{l},~V_{O},~I_{l},~{\rm and}~I_{O}$ refer to I/O pins. V_{lN} refers to the control inputs. All typical values are at V_{CC} = 3.3 V (unless otherwise noted), T_{A} = 25°C. $r_{ON(flat)}$ is the difference of r_{ON} in a given channel at specified voltages. Δr_{ON} is the difference of r_{ON} from center (A4, A5) ports to any other port.

ELECTRICAL CHARACTERISTICS

for 10/100 Base-T Ethernet switching over recommended operating free-air temperature range, V_{CC} = 3.3 V ± 0.3 V (unless otherwise noted)

PAR	AMETER		TEST CO	NDITIONS ⁽¹⁾		MIN	TYP ⁽²⁾	MAX	UNIT
V_{IK}	SEL	$V_{CC} = 3.6 \text{ V},$	I _{IN} = -18 mA		-0.7	-1.2	V		
I _{IH}	SEL	$V_{CC} = 3.6 \text{ V},$	$V_{IN} = V_{CC}$					±1	μΑ
$I_{\rm IL}$	SEL	$V_{CC} = 3.6 \text{ V},$	$V_{IN} = GND$					±1	μΑ
I _{CC}		$V_{CC} = 3.6 \text{ V},$	$I_{I/O} = 0,$	Switch ON or OFF			250	500	μΑ
C _{IN}	SEL	f = 1 MHz,	V _{IN} = 0				2	2.5	pF
C _{OFF}	B port	$V_I = 0$,	f = 1 MHz,	Outputs open,	Switch OFF		2.5	4	pF
C _{ON}		$V_I = 0$,	f = 1 MHz,	Outputs open,	Switch ON		8		рF
r _{ON}		$V_{CC} = 3 V$,	$1.25 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{CC}},$	$I_O = -10$ mA to -30 mA			4	6	Ω
r _{ON(flat)}	(3)	V _{CC} = 3 V,	$V_I = 1.25 \text{ V} \text{ and } V_{CC},$	$I_{O} = -10 \text{ mA to } -30 \text{ mA}$			0.5		Ω
$\Delta r_{ON}^{(4)}$		$V_{CC} = 3 V$,	$1.25 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{CC}},$	$I_{O} = -10 \text{ mA to } -30 \text{ mA}$			0.4	1	Ω

- $\begin{array}{lll} \text{(1)} & V_{\text{I}}, \ V_{\text{O}}, \ I_{\text{I}}, \ \text{and} \ I_{\text{O}} \ \text{refer} \ \text{to} \ \text{I/O} \ \text{pins.} \ V_{\text{IN}} \ \text{refers} \ \text{to} \ \text{the} \ \text{control} \ \text{inputs.} \\ \text{(2)} & \text{All typical values are at} \ V_{\text{CC}} = 3.3 \ \text{V} \ \text{(unless otherwise noted)}, \ T_{\text{A}} = 25^{\circ}\text{C}. \\ \text{(3)} & r_{\text{ON}(\text{flat})} \ \text{is} \ \text{the} \ \text{difference} \ \text{of} \ r_{\text{ON}} \ \text{in} \ \text{a} \ \text{given} \ \text{channel} \ \text{at specified} \ \text{voltages.} \\ \text{(4)} & \Delta r_{\text{ON}} \ \text{is} \ \text{the} \ \text{difference} \ \text{of} \ r_{\text{ON}} \ \text{from} \ \text{center} \ (A_4, A_5) \ \text{ports} \ \text{to} \ \text{any} \ \text{other} \ \text{port.} \\ \end{array}$

Submit Documentation Feedback

TS3L4892 16-BIT TO 8-BIT SPDT GIGABIT LAN SWITCH WITH LED SWITCH

SCDS251-MARCH 2008

SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, V_{CC} = 3.3 V ± 0.3 V, R_L = 200 Ω , C_L = 10 pF (unless otherwise noted) (see Figures 4 and 5)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP ⁽¹⁾	MAX	UNIT
t _{pd} ⁽²⁾	A or B	B or A		40		ps
t _{PZH} , t _{PZL}	SEL	A or B	0.5		15	ns
t _{PHZ} , t _{PLZ}	SEL	A or B	0.9		9	ns
t _{sk(o)} (3)	A or B	B or A		50	100	ps
t _{sk(p)} (4)				50	150	ps

DYNAMIC CHARACTERISTICS

over recommended operating free-air temperature range, V_{CC} = 3.3 V ± 0.3 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS							
X _{TALK}	$R_L = 100 \Omega$,	f = 250 MHz,	See Figure 8	-37	dB				
O _{IRR}	$R_L = 100 \Omega$,	f = 250 MHz,	See Figure 9	-37	dB				
BW	$R_L = 100 \Omega$,	See Figure 7		1100	MHz				

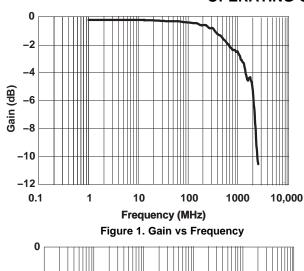
(1) All typical values are at V_{CC} = 3.3 V (unless otherwise noted), T_A = 25°C.

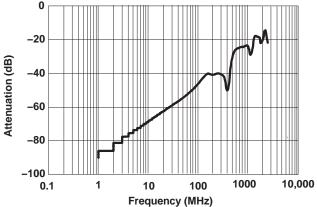
All typical values are at V_{CC} = 3.3 V (unless otherwise noted), T_A = 25°C. The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance when driven by an ideal voltage source (zero output impedance).

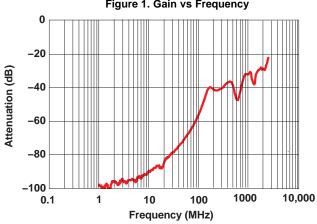
Output skew between center port (A_4 to A_5) to any other port Skew between opposite transitions of the same output in a given device $|t_{PHL}-t_{PLH}|$



OPERATING CHARACTERISTICS







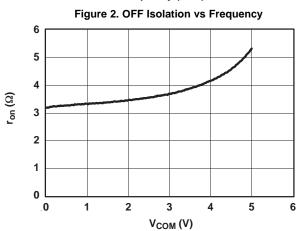
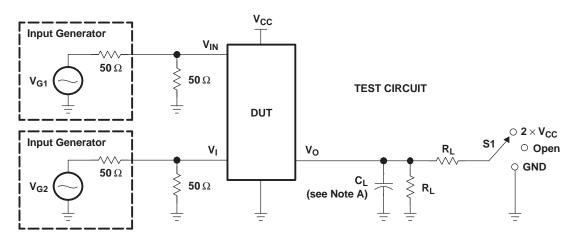


Figure 3. Crosstalk vs Frequency

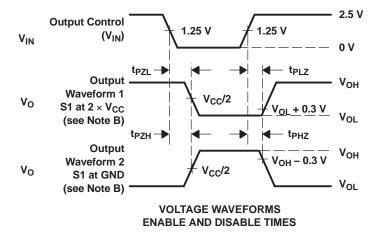
Figure 4. r_{ON} (Ω) vs V_{com} (V)



PARAMETER MEASUREMENT INFORMATION (Enable and Disable Times)



TEST	V _{CC}	S1	R_L	VI	CL	${f V}_{\Delta}$
t _{PLZ} /t _{PZL}	3.3 V \pm 0.3 V	2×V _{CC}	200 Ω	GND	10 pF	0.3 V
t _{PHZ} /t _{PZH}	3.3 V ± 0.3 V	GND	200 Ω	V _{CC}	10 pF	0.3 V



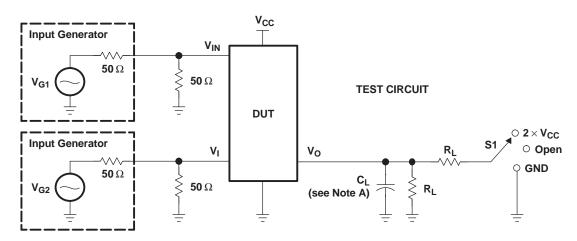
NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_{O} = 50 Ω , $t_{f} \leq$ 2.5 ns. $t_{f} \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en}.

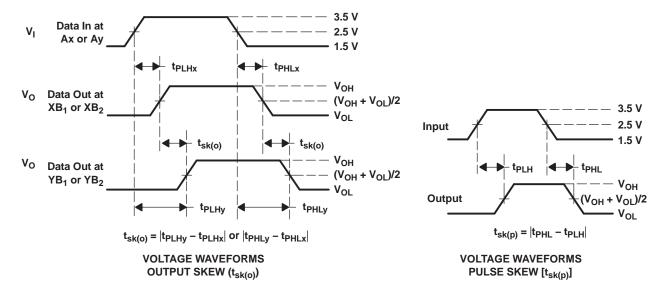
Figure 5. Test Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION (Skew)



TEST	V _{CC}	S1	R _L	V _{in}	CL
t _{sk(o)}	3.3 V ± 0.3 V	Open	200 Ω	V _{CC} or GND	10 pF
t _{sk(p)}	3.3 V ± 0.3 V	Open	200 Ω	V _{CC} or GND	10 pF



NOTES: A. C_L includes probe and jig capacitance.

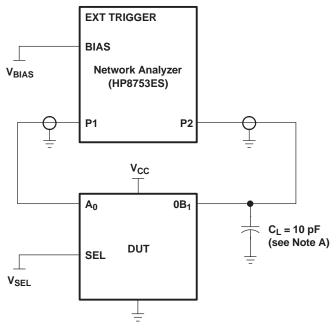
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns. $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 6. Test Circuit and Voltage Waveforms





PARAMETER MEASUREMENT INFORMATION



A. C_L includes probe and jig capacitance.

Figure 7. Test Circuit for Frequency Response (BW)

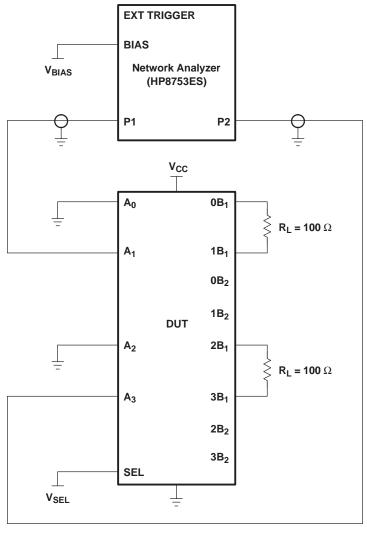
Frequency response is measured at the output of the ON channel. For example, when $V_{SEL}=0$ and A_0 is the input, the output is measured at $0B_1$. All unused analog I/O ports are left open.

HP8753ES Setup

Average = 4 RBW = 3 kHz V_{BIAS} = 0.35 V ST = 2 s P1 = 0 dBM



PARAMETER MEASUREMENT INFORMATION (continued)



- A. C_L includes probe and jig capacitance.
- B. A 50-Ω termination resistor is needed to match the loading of the network analyzer.

Figure 8. Test Circuit for Crosstalk (X_{TALK})

Crosstalk is measured at the output of the nonadjacent ON channel. For example, when $V_{SEL}=0$ and A_0 is the input, the output is measured at $1B_1$. All unused analog input (A) ports are connected to GND, and output (B) ports are connected to GND through $50-\Omega$ pulldown resistors.

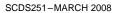
HP8753ES Setup

Average = 4 RBW = 3 kHz

 $V_{BIAS} = 0.35 V$

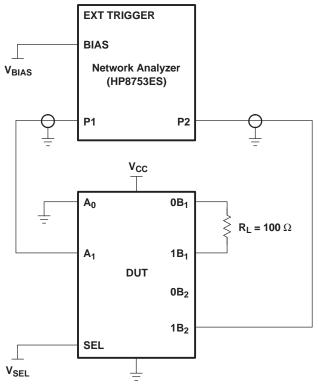
ST = 2 s

P1 = 0 dBM





PARAMETER MEASUREMENT INFORMATION (continued)



- C_L includes probe and jig capacitance.
- B. A $50-\Omega$ termination resistor is needed to match the loading of the network analyzer.

Figure 9. Test Circuit for Off Isolation (OIRR)

OFF isolation is measured at the output of the OFF channel. For example, when VSEL = V_{CC} and A_0 is the input, the output is measured at $0B_2$. All unused analog input (A) ports are left open, and output (B) ports are connected to GND through $50-\Omega$ pulldown resistors.

HP8753ES Setup

Average = 4

RBW = 3 kHz

 $V_{BIAS} = 0.35 V$

ST = 2 s

P1 = 0 dBM



PACKAGE OPTION ADDENDUM

20-May-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	Pins	_	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)		(3)		(4/5)	
TS3L4892RHHR	ACTIVE	VQFN	RHH	36	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	TK4892	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

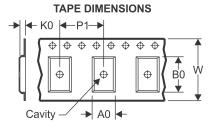
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 17-May-2014

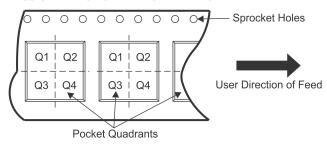
TAPE AND REEL INFORMATION





_		
		Dimension designed to accommodate the component width
		Dimension designed to accommodate the component length
		Dimension designed to accommodate the component thickness
	W	Overall width of the carrier tape
ſ	P1	Pitch between successive cavity centers

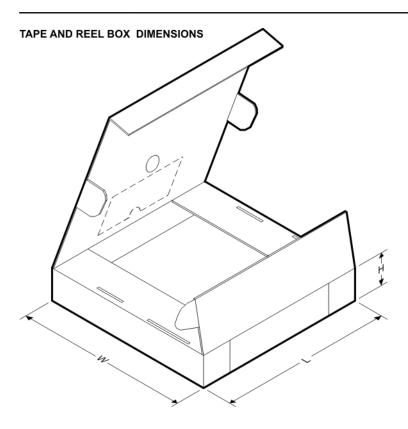
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS3L4892RHHR	VQFN	RHH	36	2500	330.0	16.4	6.3	6.3	1.1	12.0	16.0	Q2

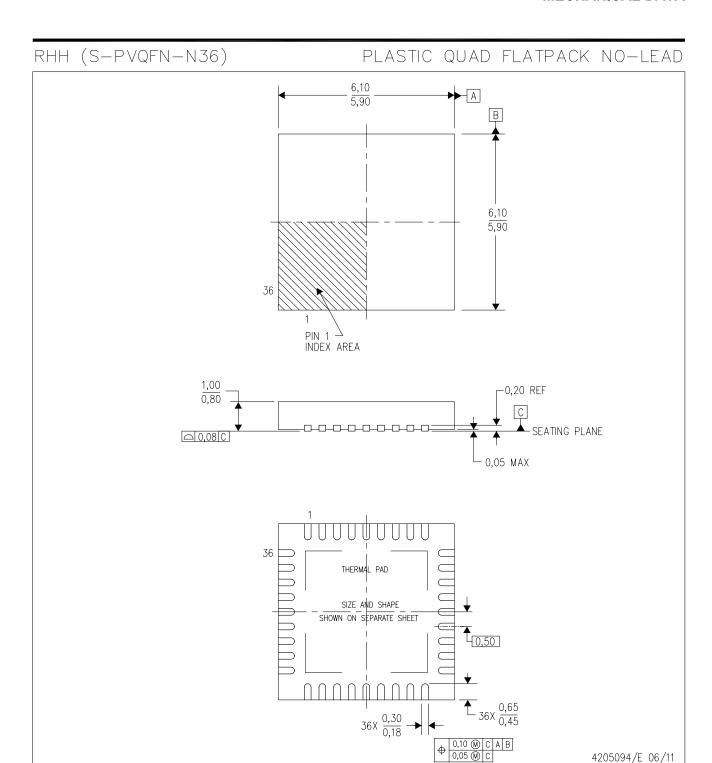
www.ti.com 17-May-2014



*All dimensions are nominal

Device		Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
	TS3L4892RHHR	VQFN	RHH	36	2500	367.0	367.0	38.0	

4205094/E 06/11



NOTES: All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) Package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance.
- See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- F. Falls within JEDEC MO-220.



RHH (S-PVQFN-N36)

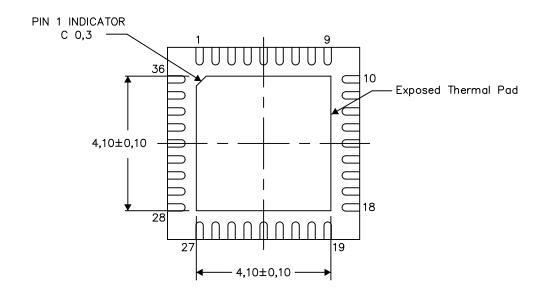
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

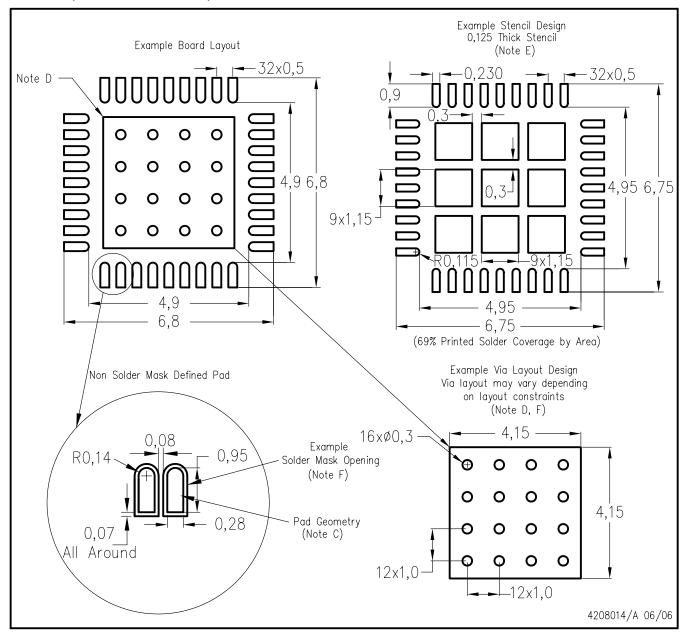
Exposed Thermal Pad Dimensions

4206362-3/M 11/13

NOTE: All linear dimensions are in millimeters



RHH (S-PQFP-N36)



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack Packages, Texas Instruments Literature No. SCBA017, SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.



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